

## Three Phase Rectifier Bridge

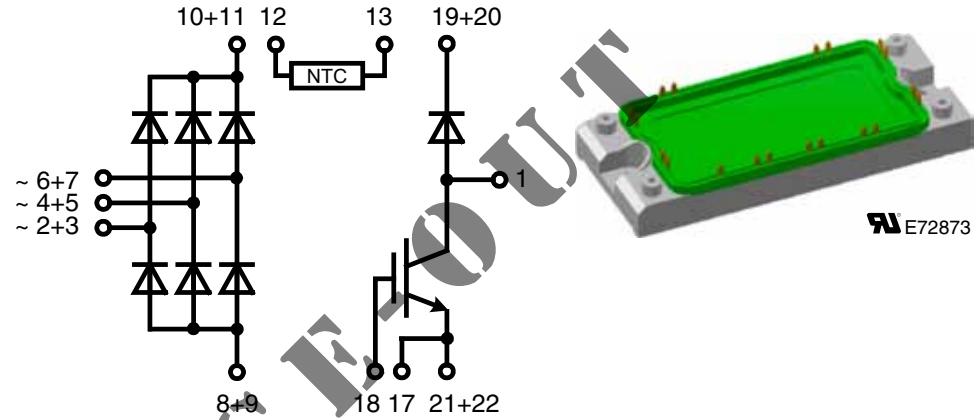
with IGBT and Fast Recovery Diode  
for Braking System

Rectifier Diode	Fast Recov. Diode	IGBT
$V_{RRM} = 1600 \text{ V}$	$V_{CES} = 1200 \text{ V}$	$V_{CES} = 1200 \text{ V}$
$I_{dAVM} = 116 \text{ A}$	$V_F = 2.76 \text{ V}$	$I_{C80} = 67 \text{ A}$
$I_{FSM} = 700 \text{ A}$	$I_{FSM} = 200 \text{ A}$	$V_{CESat} = 3.5 \text{ V}$

Preliminary data

**Part name** (Marking on product)

VUB116-16NO1



### Features:

- Soldering connections for PCB mounting
- Convenient package outline
- Optional NTC

### Application:

- Drive Inverters with brake system

### Package:

- Two functions in one package
- Easy to mount with two screws
- Suitable for wave soldering
- High temperature and power cycling capability
- UL registered, E72873

Recommended replacement:  
VUB 116-16NOXT

## IGBT

## Ratings

Symbol	Definitions	Conditions	min.	typ.	max.	Unit
$V_{CES}$	collector emitter voltage		$T_{VJ} = 25^\circ\text{C}$ to $150^\circ\text{C}$		1200	V
$V_{GES}$	max. DC gate voltage	continuous	-20		+20	V
$V_{GEM}$	max. transient collector gate voltage	transient	-30		+30	V
$I_{C25}$	collector current	DC	$T_C = 25^\circ\text{C}$		95	A
$I_{C80}$		DC	$T_C = 80^\circ\text{C}$		67	A
$P_{tot}$	total power dissipation		$T_C = 25^\circ\text{C}$		380	W
$V_{CE(sat)}$	collector emitter saturation voltage	$I_C = 100 \text{ A}; V_{GE} = 15 \text{ V}$	$T_{VJ} = 25^\circ\text{C}$		3.5	V
$V_{GE(th)}$	gate emitter threshold voltage	$I_C = 8 \text{ mA}$	$T_{VJ} = 25^\circ\text{C}$	4.5	6.45	V
$I_{CES}$	collector emitter leakage current	$V_{CE} = V_{CES}; V_{GE} = 0 \text{ V}$ $V_{CE} = 0.8 \cdot V_{CES}; V_{GE} = 0 \text{ V}$	$T_{VJ} = 25^\circ\text{C}$ $T_{VJ} = 125^\circ\text{C}$		0.1 0.5	mA mA
$C_{ies}$	input capacitance	$V_{CE} = 25 \text{ V}; V_{GE} = 0 \text{ V}; f = 1 \text{ MHz}$		3.8		nF
$t_{d(on)}$	turn-on delay time	inductive load $V_{CE} = 720 \text{ V}; I_C = 50 \text{ A}$ $V_{GE} = \pm 15 \text{ V}; R_G = 22 \Omega; L = 100 \mu\text{H}$	$T_{VJ} = 125^\circ\text{C}$	150		ns
$t_{d(off)}$	turn-off delay time			680		ns
$E_{on}$	turn-on energy per pulse			6		mJ
$E_{off}$	turn-off energy per pulse			4		mJ
$I_{CM}$	reverse bias safe operating area	RBSOA; $V_{GE} = \pm 15 \text{ V}; R_G = 22 \Omega; L = 100 \mu\text{H}$ clamped inductive load; $T_{VJ} = 125^\circ\text{C}$		100		A
$V_{CEK}$				$\leq V_{CES} \cdot L_S \cdot d/dt$		V
$t_{sc}$ (SCSOA)	short circuit safe operating area	$V_{CE} = 720 \text{ V}; V_{GE} = \pm 15 \text{ V}; R_G = 22 \Omega$ ; non-repetitive	$T_{VJ} = 125^\circ\text{C}$		10	μs
RBSOA	reverse bias safe operating area	$V_{CE} = 1200 \text{ V}; V_{GE} = \pm 15 \text{ V}; R_G = 22 \Omega; L = 100 \mu\text{H}$ ; clamped inductive load			100	A
$R_{thJC}$	thermal resistance junction to case				0.33	K/W
$R_{thCH}$	thermal resistance case to heatsink				0.33	K/W

## Fast Recovery Diode

## Ratings

Symbol	Definitions	Conditions	min.	typ.	max.	Unit
$V_{RRM}$	max. repetitive reverse voltage		$T_{VJ} = 150^\circ\text{C}$		1200	V
$I_{FAV}$	average forward current	rect.; $d = 0.5$	$T_C = 80^\circ\text{C}$		27	A
$I_{FRMS}$	rms forward current	rect.; $d = 0.5$	$T_C = 80^\circ\text{C}$		38	A
$I_{FSM}$	max. surge forward current	$t = 10 \text{ ms}$	$T_{VJ} = 45^\circ\text{C}$		200	A
$P_{tot}$	total power dissipation		$T_C = 25^\circ\text{C}$		130	W
$V_F$	forward voltage	$I_F = 30 \text{ A}$	$T_{VJ} = 25^\circ\text{C}$		2.76	V
$I_R$	reverse current	$V_R = V_{RRM}$	$T_{VJ} = 25^\circ\text{C}$ $T_{VJ} = 125^\circ\text{C}$	1	0.25	mA mA
$I_{RM}$	reverse recovery current	$I_F = 50 \text{ A}; V_R = 100 \text{ V}; di_F/dt = -100 \text{ A}/\mu\text{s}$		5.5	11	A
$t_{rr}$	reverse recovery time	$I_F = 1 \text{ A}; V_R = 30 \text{ V}; di_F/dt = -200 \text{ A}/\mu\text{s}$		40		ns
$R_{thJC}$	thermal resistance junction to case				0.9	K/W
$R_{thCH}$	thermal resistance case to heatsink				0.1	K/W

 $T_C = 25^\circ\text{C}$  unless otherwise stated

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**Rectifier Diode**

Symbol	Conditions		Ratings		
			min.	typ.	max.
$V_{RRM}$	max. repetitive reverse voltage	$T_{VJ} = 25^\circ C$		1600	V
$I_R$	reverse current	$V_R = V_{RRM}$	$T_{VJ} = 25^\circ C$ $T_{VJ} = 150^\circ C$	0.1 2	mA mA
$V_F$	forward voltage	$I_F = 80 A$	$T_{VJ} = 25^\circ C$	1.43	V
$I_{D(AV)M}$	max. average DC output current	rectangular; $d = 1/3$ ; bridge	$T_C = 80^\circ C$	116	A
$V_{FO}$	threshold voltage		$T_{VJ} = 150^\circ C$	0.85	V
$r_F$	slope resistance	for power loss calculation only		7.1	$m\Omega$
$R_{thJC}$	thermal resistance junction to case	per diode	$T_{VJ} = 25^\circ C$	0.65	K/W
$R_{thCH}$	thermal resistance case to heatsink		$T_{VJ} = 25^\circ C$	0.1	K/W
$P_{tot}$	total power dissipation		$T_{VJ} = 25^\circ C$	190	W
$I_{FSM}$	max. forward surge current	$t = 10 \text{ ms (50Hz)}$ $V_R = 0 V$	$T_{VJ} = 45^\circ C$ $T_{VJ} = 150^\circ C$	700 610	A A
$I^2t$	value for fusing	$t = 10 \text{ ms (50Hz)}$ $V_R = 0 V$	$T_{VJ} = 45^\circ C$ $T_{VJ} = 150^\circ C$	2450 1860	$A^2s$ $A^2s$

**Temperature Sensor NTC**

Symbol	Definitions	Conditions		Ratings			
				min.	typ.	max.	
$R_{25}$	resistance		$T_c = 25^\circ C$	4.75	5.0 3375	5.25	$k\Omega$ K
$B_{25/85}$							

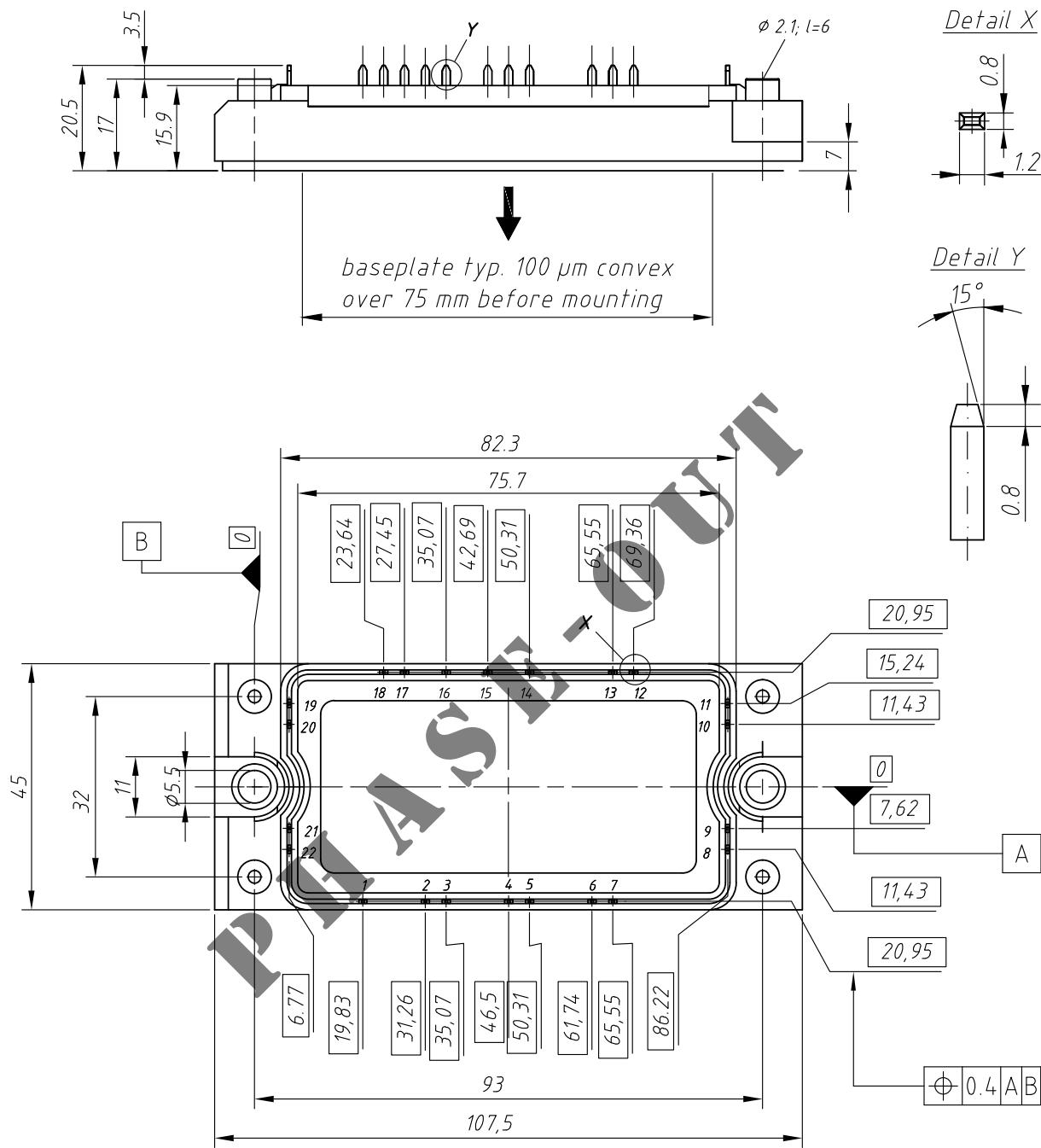
**Module**

Symbol	Definitions	Conditions		Ratings		
				min.	typ.	max.
$T_{VJ}$	operating temperature		-40		125	$^\circ C$
$T_{VJM}$	max. virtual junction temperature				150	$^\circ C$
$T_{stg}$	storage temperature		-40		125	$^\circ C$
$V_{ISOL}$	isolation voltage	$I_{ISOL} \leq 1 \text{ mA}; 50/60 \text{ Hz};$ $t = 1 \text{ min.}$ $t = 1 \text{ s}$			2500 3000	$V_\sim$ $V_\sim$
$M_d$	mounting torque	(M5)	2.7		3.3	Nm
$d_s$	creep distance on surface		12.7			mm
$d_A$	strike distance through air		9.6			mm
$a$	maximum allowable acceleration		50			$\text{m/s}^2$
$R_{pin-chip}$	thermal resistance pin to chip	$T_{VJ} = 25^\circ C$	2			$m\Omega$
<b>Weight</b>				180		g

 $T_c = 25^\circ C$  unless otherwise stated

## Outline Drawing

Dimensions in mm (1 mm = 0.0394")



## Product Marking

Ordering	Part Name	Marking on Product	Delivering Mode	Base Qty	Ordering Code
Standard	VUB 116-16NO1	VUB116-16NO1	Box	6	496855

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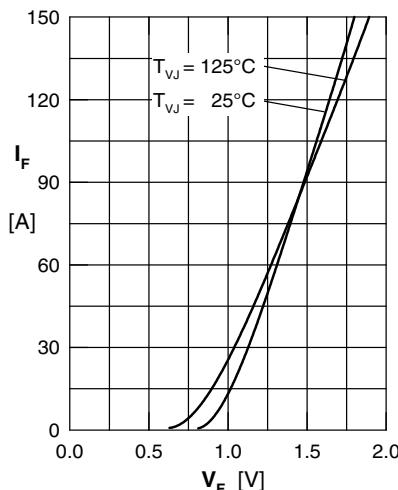


Fig. 1 Forward current vs. voltage drop per diode

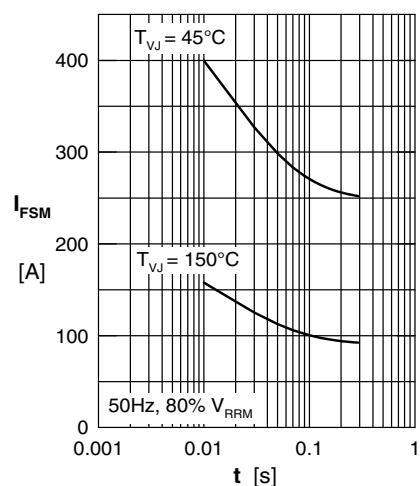


Fig. 2 Surge overload current

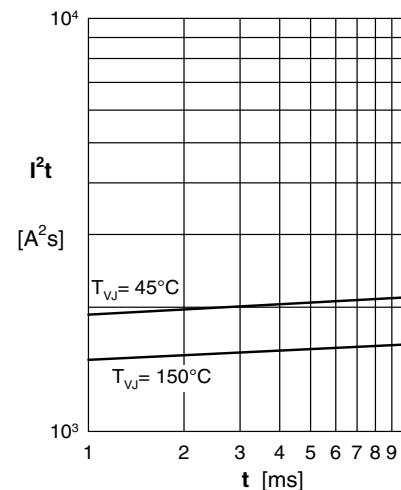
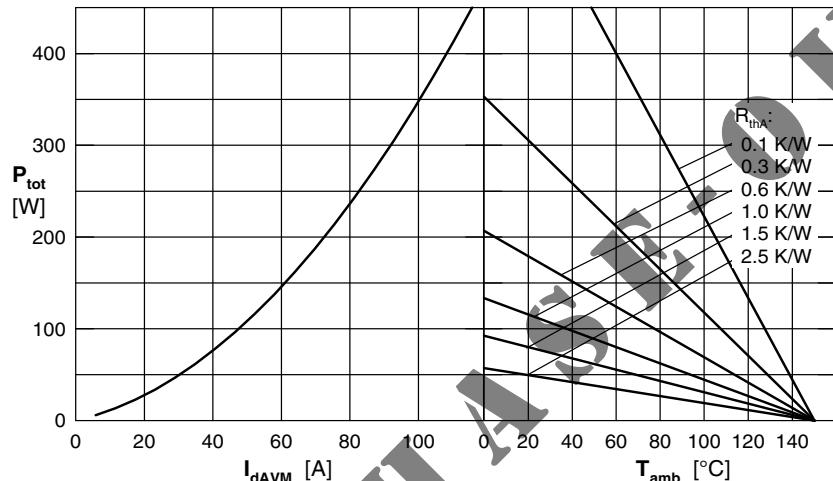
Fig. 3  $I^2t$  versus time per diode

Fig. 4 Power dissipation versus direct output current and ambient temperature, sine 180°

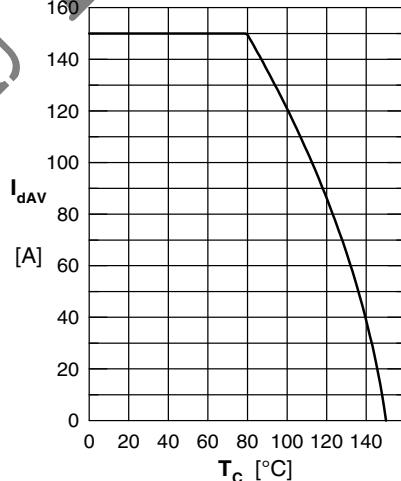


Fig. 5 Max. forward current vs. case temperature

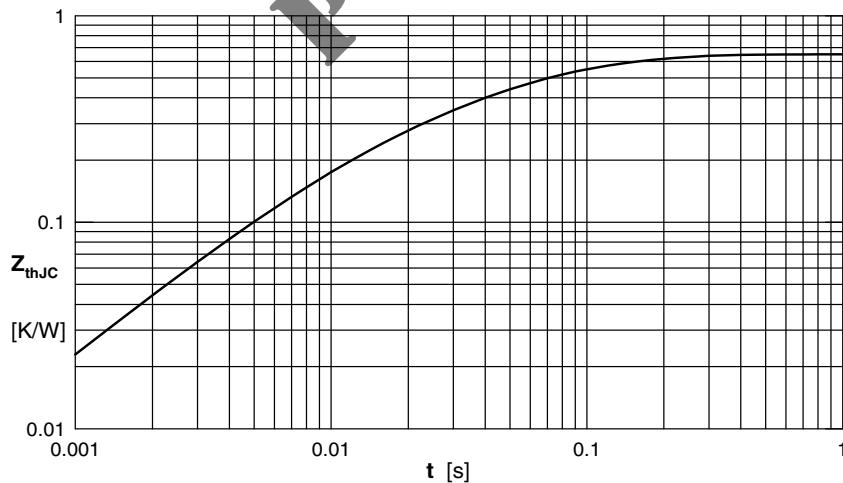


Fig. 6 Transient thermal impedance junction to case

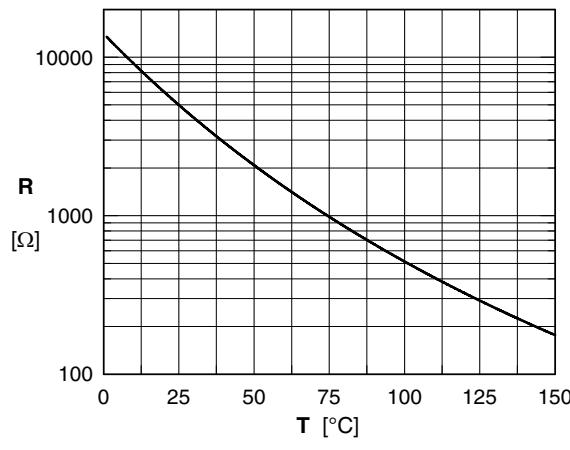
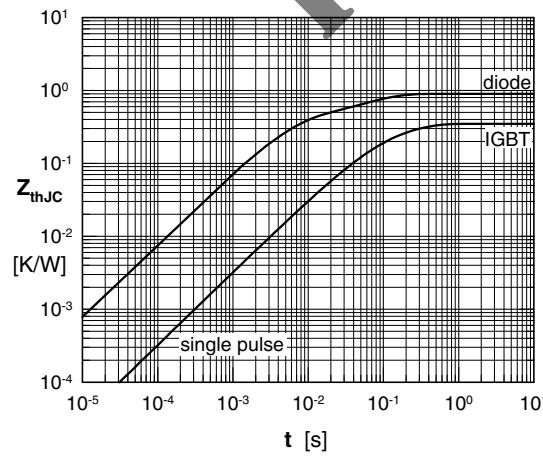
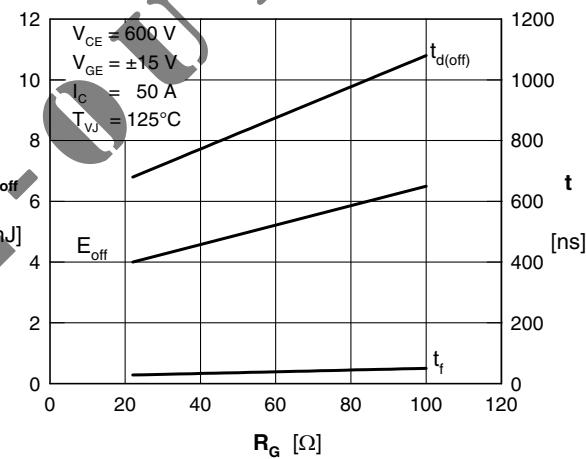
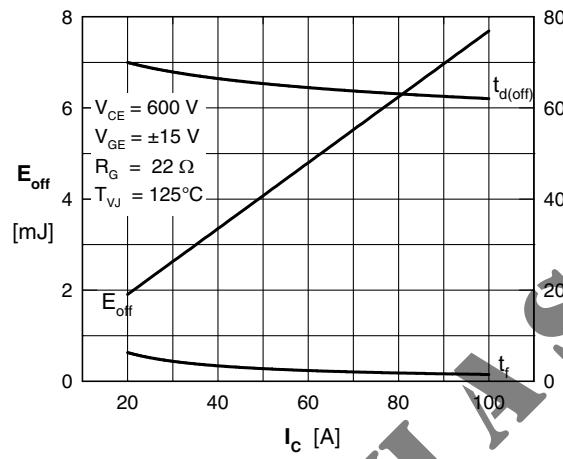
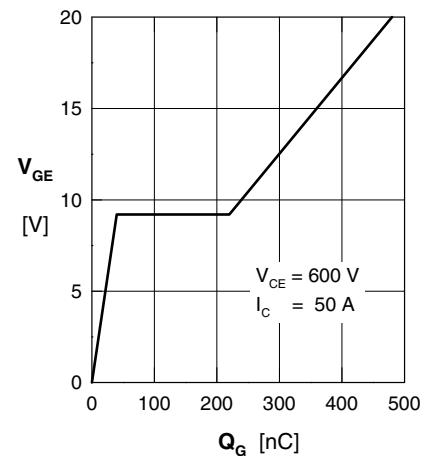
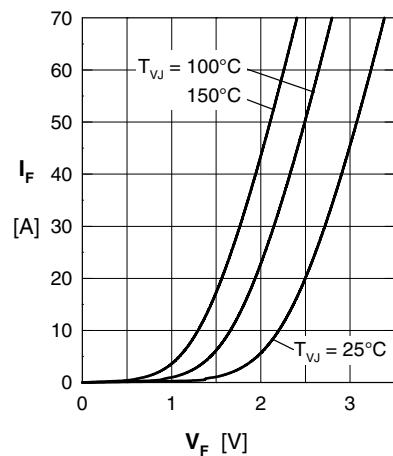
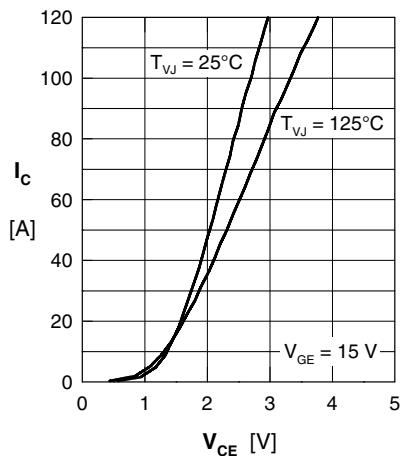
$R_i$	$\tau_i$
0.085	0.012
0.041	0.007
0.309	0.036
0.215	0.102

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